_	Application No.	Applicant(s)
A1.4	10/625,644	HIDAKA, HIDETO
Notice of Allowability	Examiner	Art Unit
	Son L. Mai	2827
The MAILING DATE of this communication appe All claims being allowable, PROSECUTION ON THE MERITS IS herewith (or previously mailed), a Notice of Allowance (PTOL-85) NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RI	(OR REMAINS) CLOSED in this app or other appropriate communication GHTS. This application is subject to	plication. If not included will be mailed in due course. THIS
1. $igotimes$ This communication is responsive to <u>Request for Continued</u>	d Examination filed 01-18-05.	
2. X The allowed claim(s) is/are <u>1-11</u> .		
3. $igotimes$ The drawings filed on <u>11 August 2004</u> are accepted by the	Examiner.	
 4. Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f). a)		
 Attachment(s) 1. Notice of References Cited (PTO-892) 2. Notice of Draftperson's Patent Drawing Review (PTO-948) 3. Information Disclosure Statements (PTO-1449 or PTO/SB/0 Paper No./Mail Date 4. Examiner's Comment Regarding Requirement for Deposit of Biological Material 	6. ☐ Interview Summary Paper No./Mail Dat 8), 7. ☐ Examiner's Amendr	te

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DETAILED ACTION

Continued Examination Under 37 CFR 1.114

1. A request for continued examination under 37 CFR 1.114, including the fee set forth in 37 CFR 1.17(e), was filed in this application after allowance or after an Office action under *Ex Parte Quayle*, 25 USPQ 74, 453 O.G. 213 (Comm'r Pat. 1935). Since this application is eligible for continued examination under 37 CFR 1.114, and the fee set forth in 37 CFR 1.17(e) has been timely paid, prosecution in this application has been reopened pursuant to 37 CFR 1.114. Applicant's submission filed on 01-18-05 has been entered.

Allowable Subject Matter

- 2. Claims 1-11 are allowed.
- 3. The following is an examiner's statement of reasons for allowance: The prior art of record fails to teach another aspect of the invention as claimed in claim 11. The claim calls for a thin film magnetic memory device comprising: power supply lines for supplying power to a current driver for supplying a data write current to bit lines, wherein the power supply lines are arranged to extend over memory regions, and no current path is formed in a region of each of the power supply lines that corresponds to a selected memory region selected for a data write operation from the memory regions.

Conclusion

4. The prior art made of record and not relied upon is considered pertinent to applicant's disclosure. The references cited in the form PTO-892 teach flowing of data write current in thin film magnetic memory devices.

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Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Son L. Mai whose telephone number is 571-272-1786. The examiner can normally be reached on 8am to 6pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Hoai Ho can be reached on 571-272-1777. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

03-04-05

Son L. Mai Primary Examiner Art Unit 2827